

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/024,096 MIER-LANGNER ET AL.	
		Examiner	Art Unit	Page 1 of 1 Quan-Zhen Wang 2633

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,567,032 B1	05-2003	Mullaly et al.	341/176
	B	US-5,128,847 A	07-1992	Lin et al.	362/226
	C	US-2002/0075386 A1	06-2002	Tanaka, Atsushi	348/141
	D	US-2001/0040805 A1	11-2001	Lansing et al.	362/276
	E	US-6,687,487 b1	02-2004	Mosebrook et al.	455/11.1
	F	US-6,655,817	12-2003	Devlin et al.	362/233
	G	US-5,072,216	12-1991	Grange, Robert	340/825.52
	H	US-4,712,167	12-1987	Gordin et al.	362/233
	I	US-4,598,345	07-1986	Kleeman, Jeff	362/233
	J	US-5,731,664	03-1998	Posa, John G.	315/194
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 3719384 A1	12-1988	Germany	BANSBACH et al.	H05B 37/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.